

IRFR220, IRFR221, IRFR222, IRFU220, IRFU221, IRFU222

3.8A and 4.6A, 150V and 200V, 0.8 and 1.2 Ohm,
N-Channel Power MOSFETs

January 1998

Features

- 3.8A and 4.6A, 150V and 200V
- $r_{DS(ON)} = 0.8\Omega$ and 1.2Ω
- Single Pulse Avalanche Energy Rated
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- Related Literature
 - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

Ordering Information

PART NUMBER	PACKAGE	BRAND
IRFR220	TO-252AA	IFR220
IRFR221	TO-252AA	IFR221
IRFR222	TO-252AA	IFR222
IRFU220	TO-251AA	IFU220
IRFU221	TO-251AA	IFU221
IRFU222	TO-251AA	IFU222

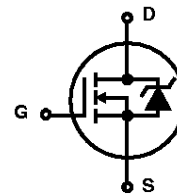
NOTE: When ordering, use the entire part number.

Description

These are N-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

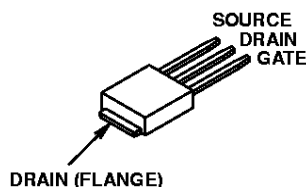
Formerly developmental type TA9600.

Symbol

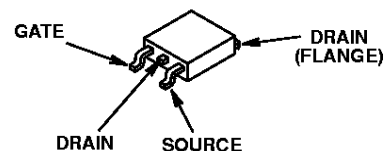


Packaging

JEDEC TO-251 AA



JEDEC TO-252AA



IRFR220, IRFR221, IRFR222, IRFU220, IRFU221, IRFU222

Absolute Maximum Ratings $T_C = 25^\circ\text{C}$, Unless Otherwise Specified

	IRFR220 IRFU220	IRFR221 IRFU221	IRFR222 IRFU222	UNITS	
Drain to Source Voltage (Note 1)	V_{DS}	200	150	200	V
Drain to Gate Voltage ($R_{GS} = 20\text{k}\Omega$) (Note 1)	V_{DGR}	200	150	200	V
Continuous Drain Current (Note 3)	I_D	4.6	4.6	3.8	A
$T_C = 100^\circ\text{C}$	I_D	2.9	2.9	2.4	A
Pulsed Drain Current	I_{DM}	18	18	15	A
Gate to Source Voltage	V_{GS}	± 20	± 20	± 20	V
Maximum Power Dissipation	P_D	50	50	50	W
Linear Derating Factor		0.4	0.4	0.4	$\text{W}/^\circ\text{C}$
Single Pulse Avalanche Energy Rating (Note 4)	E_{AS}	85	85	85	mJ
Operating and Storage Temperature	T_J, T_{STG}	-55 to 150	-55 to 150	-55 to 150	$^\circ\text{C}$
Maximum Temperature for Soldering					
Leads at 0.063in (1.6mm) from Case for 10s	T_L	300	300	300	$^\circ\text{C}$
Package Body for 10s, See Techbrief 334	T_{pk}	260	260	260	$^\circ\text{C}$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

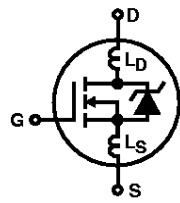
- $T_J = 25^\circ\text{C}$ to 125°C .

Electrical Specifications $T_C = 25^\circ\text{C}$, Unless Otherwise Specified

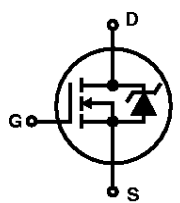
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage IRFR220, IRFU220 IRFR221, IRFU221 IRFR222, IRFU222	BV_{DSS}	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$, (Figure 10)	200	-	-	V
			150	-	-	V
			200	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	2.0	-	4.0	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = \text{Rated } BV_{DSS}, V_{GS} = 0\text{V}$	-	-	25	μA
		$V_{DS} = 0.8 \times \text{Rated } BV_{DSS}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$	-	-	250	μA
On-State Drain Current (Note 2) IRFR220, IRFU220 IRFR221, IRFU221 IRFR222, IRFU222	$I_{D(ON)}$	$V_{DS} > I_{D(ON)} \times r_{DS(ON)MAX}, V_{GS} = 10\text{V}$, (Figure 7)	4.6	-	-	A
			4.6	-	-	A
			3.8	-	-	A
Gate to Source Leakage Current	I_{GSS}	$V_{GS} = \pm 20\text{V}$	-	-	± 100	nA
Drain to Source On Resistance (Note 2) IRFR220, IRFU220 IRFR221, IRFU221 IRFR222, IRFU222	$r_{DS(ON)}$	$I_D = 2.4\text{A}, V_{GS} = 10\text{V}$, (Figures 8, 9)	-	0.47	0.80	Ω
			-	0.47	0.80	Ω
			-	0.80	1.2	Ω
Forward Transconductance (Note 2)	g_{fs}	$V_{DS} \geq 50\text{V}, I_D = 2.4\text{A}$, (Figure 12)	1.7	2.6	-	S
Turn-On Delay Time	$t_{d(ON)}$	$V_{DD} = 100\text{V}, I_D \approx 4.6\text{A}, R_G = 18\Omega, R_L = 18\Omega,$ $V_{GS} = 10\text{V}$, (Figures 17, 18) MOSFET Switching Times are Essentially Independent of Operating Temperature	-	8.8	13	ns
Rise Time	t_r		-	27	41	ns
Turn-Off Delay Time	$t_{d(OFF)}$		-	21	32	ns
Fall Time	t_f		-	14	21	ns

IRFR220, IRFR221, IRFR222, IRFU220, IRFU221, IRFU222

Electrical Specifications $T_C = 25^\circ\text{C}$, Unless Otherwise Specified (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Total Gate Charge (Gate to Source + Gate to Drain)	$Q_{g(\text{TOT})}$	$V_{GS} = 10\text{V}$, $I_D = 4.6\text{A}$, $V_{DS} = 0.8 \times \text{Rated } BV_{DS}$, $I_{G(\text{REF})} = 1.5\text{mA}$, (Figures 14, 19, 20) Gate Charge is Essentially Independent of Operating Temperature		-	12	18	nC
Gate to Source Charge	Q_{gs}			-	2.3	3.4	nC
Gate to Drain "Miller" Charge	Q_{gd}			-	4.5	6.8	nC
Input Capacitance	C_{ISS}	$V_{DS} = 25\text{V}$, $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$, (Figure 11)		-	330	-	pF
Output Capacitance	C_{OSS}			-	120	-	pF
Reverse Transfer Capacitance	C_{RSS}			-	41	-	pF
Internal Drain Inductance	L_D	Measured From the Drain Lead, 6.0mm (0.25in) From Package to Center of Die	Modified MOSFET Symbol Showing the Internal Device Inductances 	-	4.5	-	nH
Internal Source Inductance	L_S	Measured From the Source Lead, 6.0mm (0.25in) From Package to Source Bonding Pad		-	7.5	-	nH
Thermal Resistance, Junction to Case	$R_{\theta JC}$			-	-	2.5	$^\circ\text{C/W}$
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	Typical Solder Mount		-	-	110	$^\circ\text{C/W}$

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I_{SD}	Modified MOSFET Symbol Showing the Integral Reverse P-N Junction Rectifier 		-	-	4.6	A
Pulse Source to Drain Current (Note 3)	I_{SDM}			-	-	18	A
Source to Drain Diode Voltage (Note 2)	V_{SD}	$T_J = 25^\circ\text{C}$, $I_{SD} = 4.6\text{A}$, $V_{GS} = 0\text{V}$, (Figure 13)		-	-	1.8	V
Reverse Recovery Time	t_{rr}	$T_J = 25^\circ\text{C}$, $I_{SD} = 4.6\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$		69	170	400	ns
Reverse Recovery Charge	Q_{RR}	$T_J = 25^\circ\text{C}$, $I_{SD} = 4.6\text{A}$, $dI_{SD}/dt = 100\text{A}/\mu\text{s}$		0.30	0.72	1.8	μC

NOTES:

2. $T_J = 25^\circ\text{C}$ to 150°C .
3. Pulse test: pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
4. Repetitive rating: pulse width limited by maximum junction temperature. See Transient Thermal Impedance curve (Figure 3).
5. $V_{DD} = 10\text{V}$, starting $T_J = 25^\circ\text{C}$, $L = 6.18\text{mH}$, $R_G = 50\Omega$, peak $I_{AS} = 4.6\text{A}$.

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Typical Performance Curves Unless Otherwise Specified

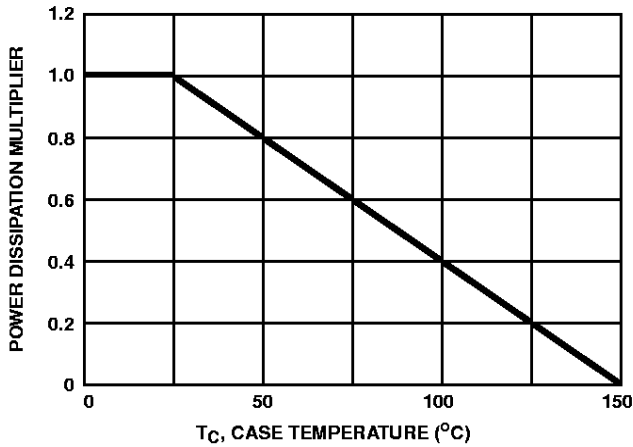


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

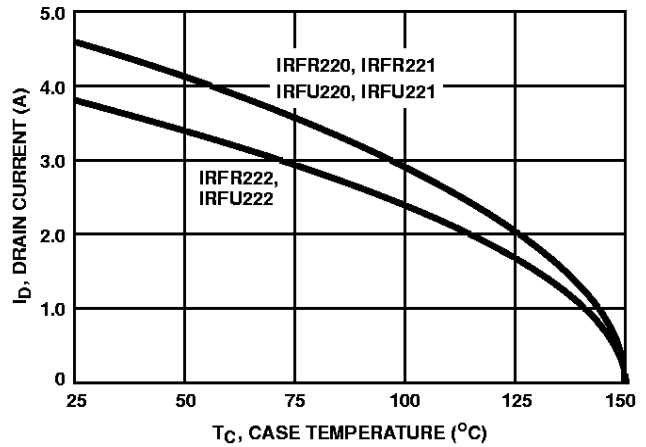


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

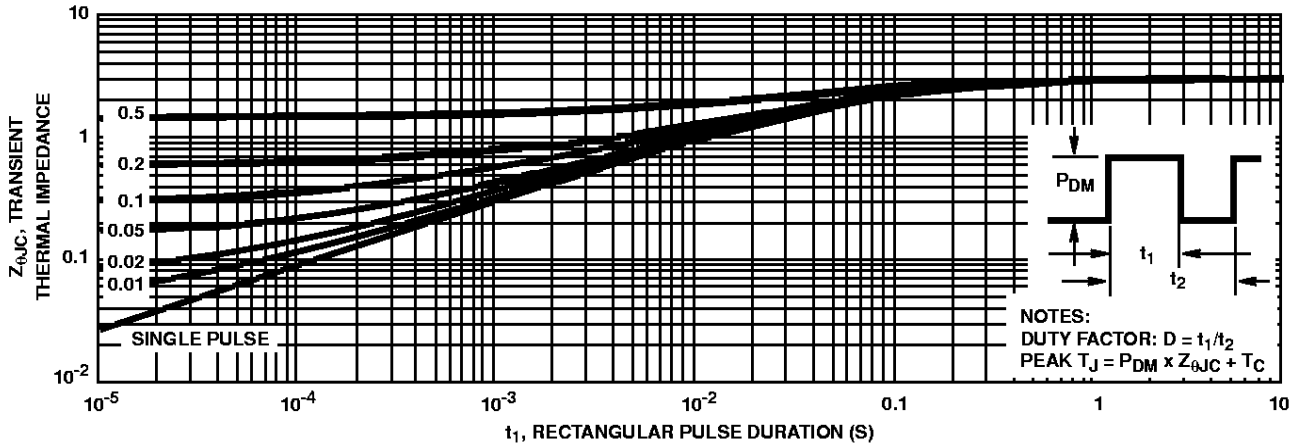


FIGURE 3. MAXIMUM TRANSIENT THERMAL IMPEDANCE

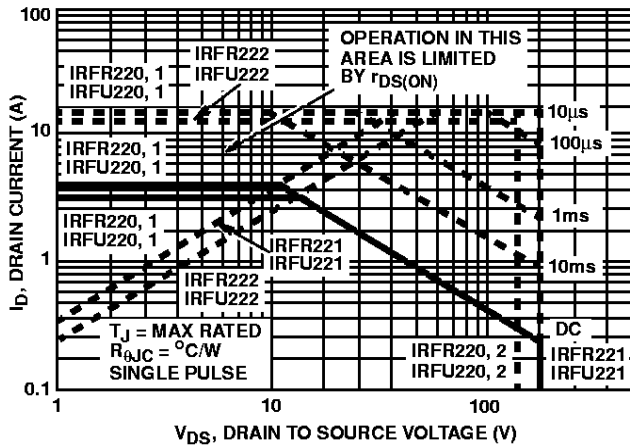


FIGURE 4. FORWARD BIAS SAFE OPERATING AREA

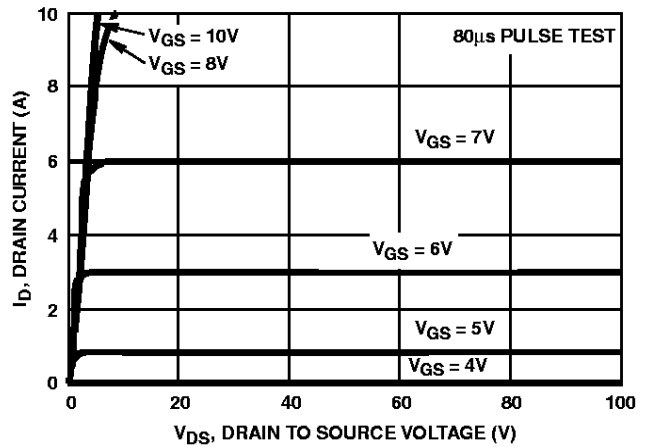


FIGURE 5. OUTPUT CHARACTERISTICS

Typical Performance Curves Unless Otherwise Specified (Continued)

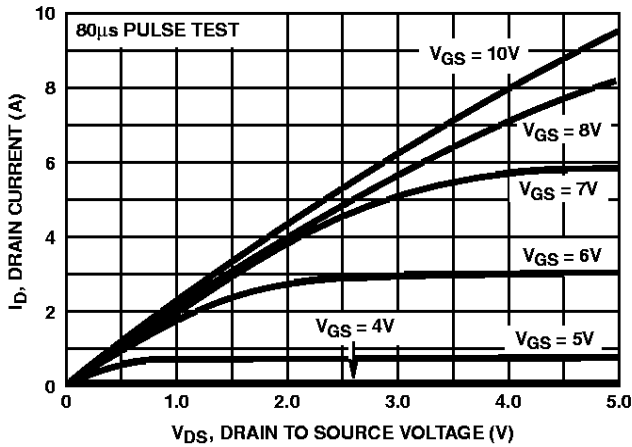


FIGURE 6. SATURATION CHARACTERISTICS

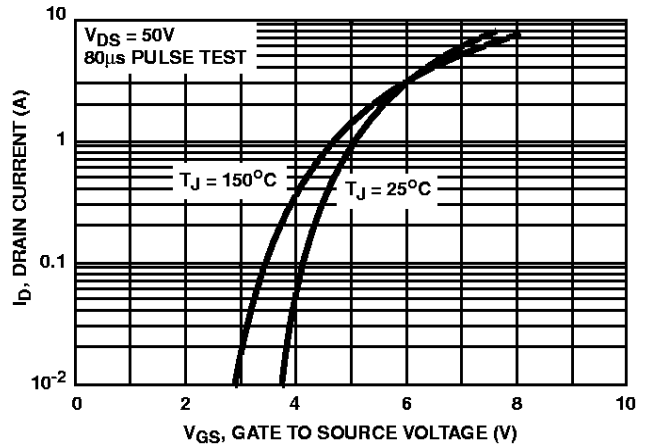


FIGURE 7. TRANSFER CHARACTERISTICS

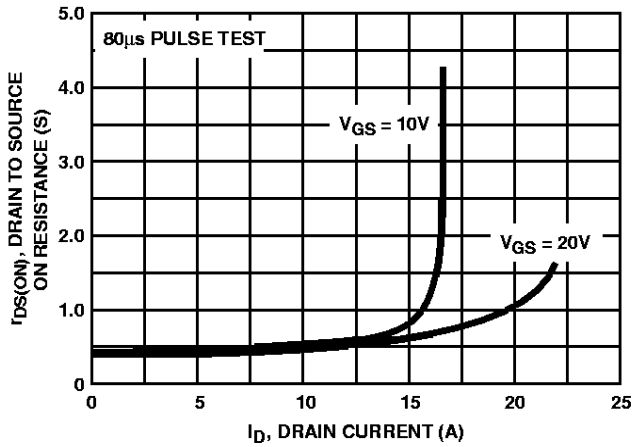


FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

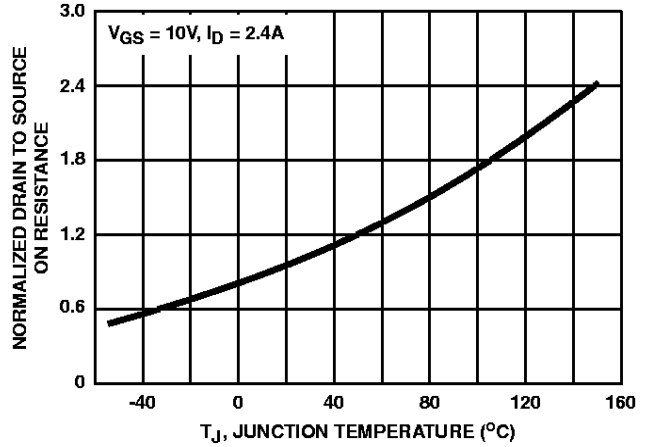


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

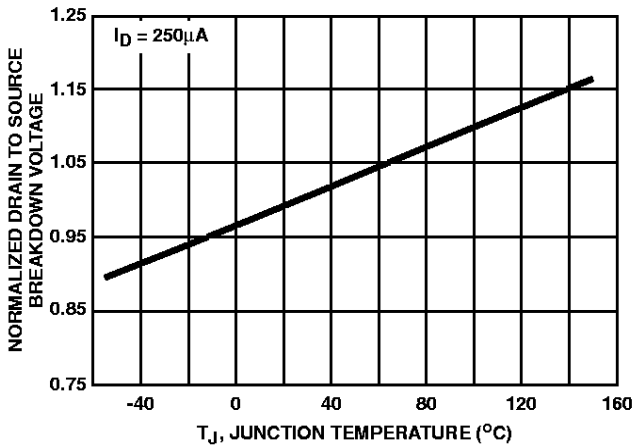


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

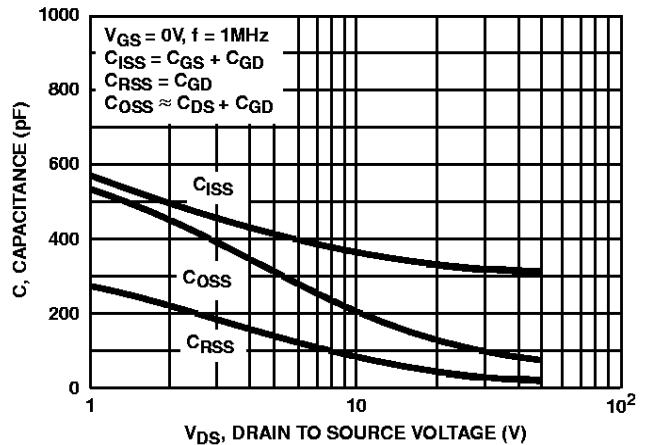


FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

Typical Performance Curves Unless Otherwise Specified (Continued)

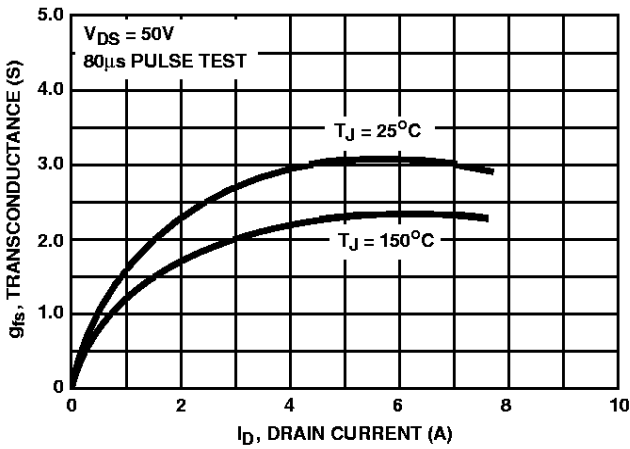


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

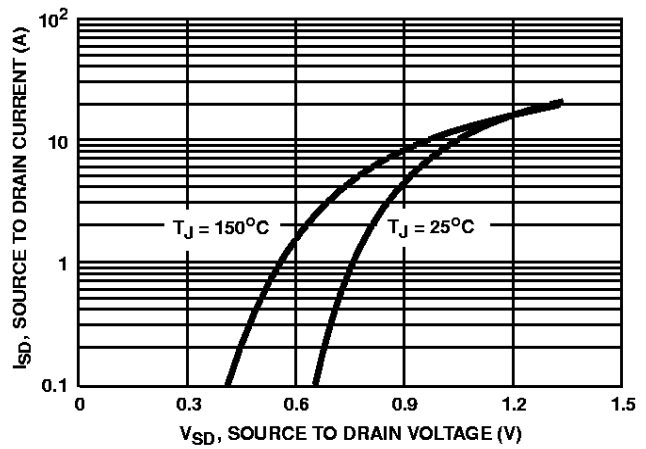


FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

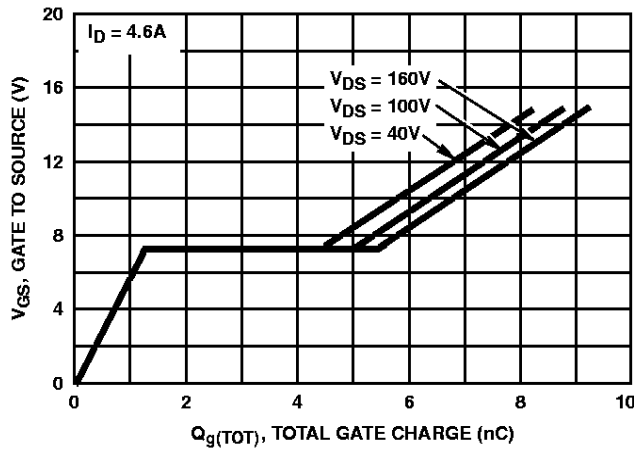


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

Test Circuits and Waveforms

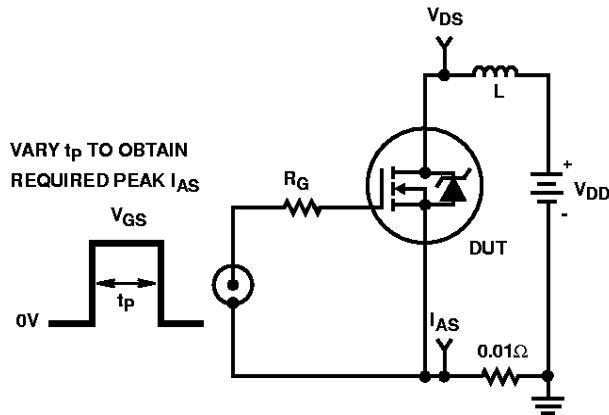


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

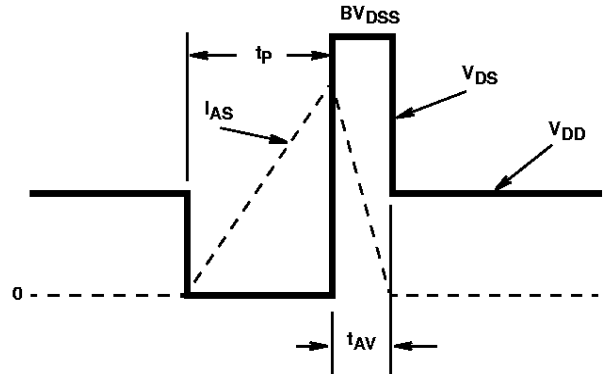


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

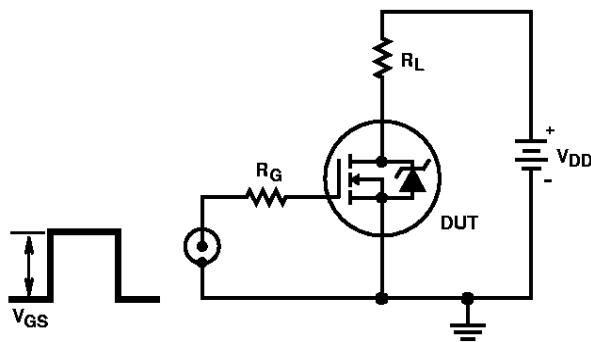


FIGURE 17. SWITCHING TIME TEST CIRCUIT

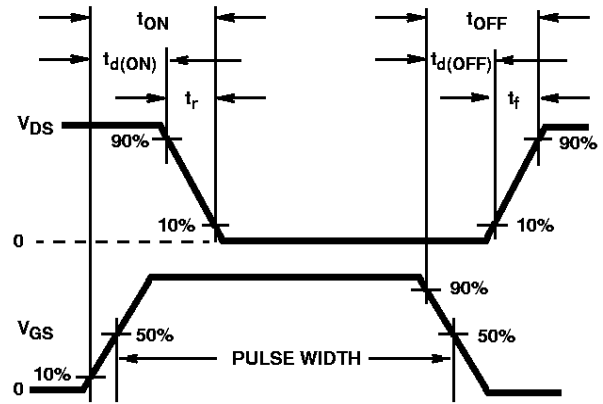


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

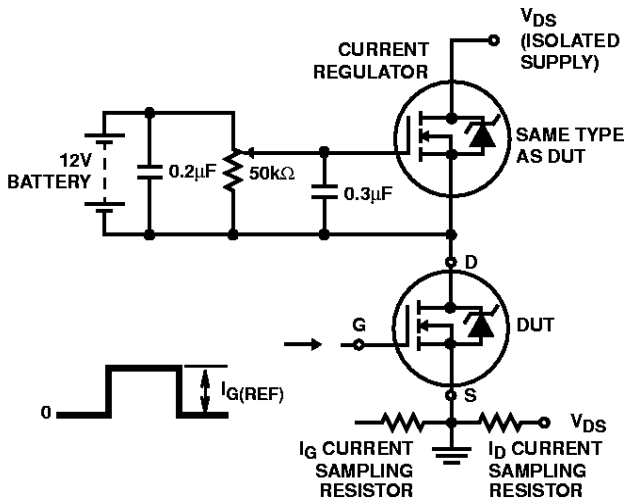


FIGURE 19. GATE CHARGE TEST CIRCUIT

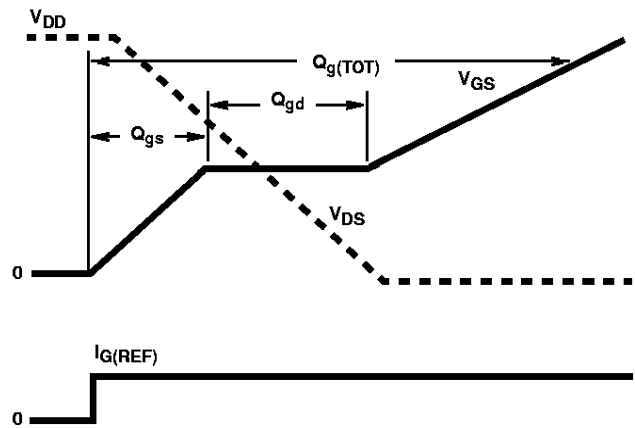


FIGURE 20. GATE CHARGE WAVEFORMS